

1.5A, Rad Hard, Positive, High Voltage LDO

ISL75052SRH

The ISL75052SRH is a radiation hardened, single output LDO specified for an output current of upto 1.5A. The device operates from an input voltage range of 4.0V to 13.2V and provides for output voltages of 0.6V to 12.7V. The output is adjustable based on a resistor divider setting. Dropout voltages as low as 200mV worst case can be realized using the device

The ENABLE feature allows the part to be placed into a low shutdown current mode of 10µA typ. When enabled the device operates with a low ground current of 11mA typ which provides for operation with Low Quiescent Power consumption.

The device has good transient response and designed keeping Single Event Effects in mind. This results in reduction of the magnitude of SET seen on the output. There is no need for additional protection diodes and filters.

COMP pin is provided to enable the use of external compensation. This is achieved by connecting a resistor and capacitor from COMP to ground.

The device is stable with Tantalum capacitors as low as 47µF and provides excellent regulation all the way from no Load to full Load. The programmable soft start allows one to program the inrush current by means of the decoupling capacitor value used on the BYP pin.

The OCP pin allows the short circuit output current limit threshold to be programmed by means of a resistor from OCP pin to GND. The OCP setting range is from a 0.25A min to 4.25A max. The resistor sets the constant current threshold for the output under fault conditions. The thermal shutdown disables the output if the device temperature exceeds the specified value, it will subsequently enter a ON/OFF cycle till the fault is removed.

Features

- DSCC SMD#5962-F-xxxxx
- Input supply range 4.0V to 13.2V.
- Output Current up to 1.5A at a $T_J=150^{\circ}\text{C}$
- Output Accuracy $\pm 1.5\%$ Guaranteed over MIL temp range.
- Ultra Low Dropout:
 - 200mV Dropout @ 0.5A
 - 500mV Dropout @ 1.5A
- Noise of 100µV_{RMS} between 300Hz to 300kHz
- SET mitigation with no added filtering/diodes
- Shutdown Current of 10µA Typ.
- Output Adjustable using preset resistors
- PSRR 60dB Typical @ 1kHz
- ENable and PGood Feature
- Programmable Soft Start / Inrush Current Limiting
- Adjustable Over Current Protection
- Over-Temperature Shutdown
- Stable with 47µF Min Tantalum Capacitor
- Package 16 Ld Flat Pack
- Radiation Environment
 - High Dose100 krad(Si)
 - Low Dose100 krad(Si)
 - SET/SEL/SEB86 MeV.cm²/mg

Applications

- LDO regulator for Space Power Systems
- DSP, FPGA and µP Core Power Supplies
- Post Regulation of Switched Mode Power Supplies
- Down Hole Drilling

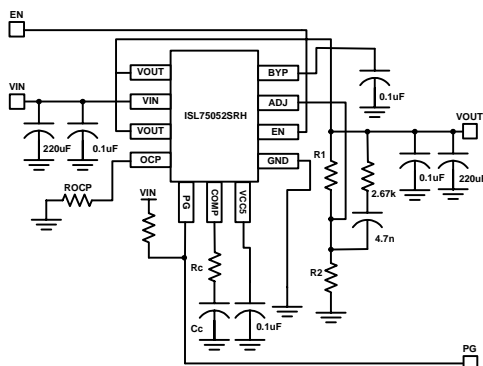


FIGURE 1. TYPICAL APPLICATION

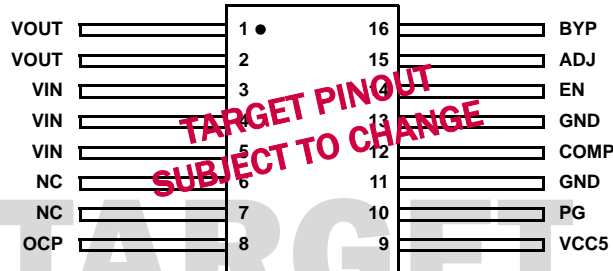
FIGURE 2. DROPOUT VS IOU

THIS IS A PRE-DEVELOPMENT TARGET DATASHEET. DEVICE FUNCTIONALITY AND SPECIFICATIONS ARE SUBJECT TO CHANGE

ISL75052SRH

Pin Configuration

ISL75052SRH
(16Ld CDFP)
TOP VIEW



Pin Descriptions

PIN NUMBER	PIN NAME	DESCRIPTION
3,4,5	V _{IN}	Input supply pins.
10	PG	This pin is logic high when V _{OUT} is in regulation signal. A logic low defines when V _{OUT} is not in regulation. Must be grounded if not used.
11,13	GND	GND pin. This pin is also connected to the metal lid of the package
9	VCC5	The 5V internal bus is pinned out to accept a decoupling capacitor.
1,2	V _{OUT}	Output voltage pins.
12	COMP	Add compensation capacitor & resistor between COMP and GND, C=1nF typ & R=40kΩ typ
15	VADJ	VADJ pin allows V _{OUT} to be programmed with an external resistor divider.
6,7,11		No connect
16	BYP	Connect a 0.2μF capacitor from BYP pin to GND, to filter the internal VREF.
8	OCP	OCP pin allows the Current limit to be programmed with an external resistor
14	EN	V _{IN} independent chip enable. TTL and CMOS compatible.

Ordering Information

ORDERING NUMBER	INTERNAL MKT. NUMBER	PART MARKING	TEMP RANGE (°C)	PACKAGE Tape & Reel (Pb-free)	PKG DWG. #
5962-xxxxxxxxxx	ISL75052SRHVF-T	TBD	-55 to +125	16 Ld CDFP	K16.A
5962-xxxxxxxxxx	ISL75052SRHQF-T	TBD	-55 to +125	16 Ld CDFP	K16.A
5962-xxxxxxxxxx	ISL75052SRHVX-T	TBD	-55 to +125	Die	TBD
ISL75052SRHF/Sample	ISL75052SRHF/Sample	TBD	-55 to +125	Die Sample	TBD
ISL75052SRHF/Proto	ISL75052SRHF/Proto	TBD	-55 to +125	16 Ld CDFP	K16.A

NOTE:

- These Intersil Pb-free Hermetic packaged products employ 100% Au plate - e4 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations.

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Absolute Maximum Ratings

V_{IN} Relative to GND (Note 2) -0.3 to +14.7V
 V_{OUT} Relative to GND (Note 2) -0.3 to +14.7V
 PG,EN,OCF/ADJ,COMP,REFIN,REFOUT relative to GND (Note 6) ... -0.3 to +6.5VDC

Recommended Operating Conditions (Notes 10, 11)

Ambient Temperature Range (T_A) (Note 5) -55°C to +125°C
 Junction Temperature (T_J) (Note 5) +150°C
 V_{IN} Relative to GND 4.0V to 13.2V
 V_{OUT} Range 2.5V to 12.7V
 PG, EN, OCF/ADJ relative to GND 0V to +5.5V

Thermal Information

Thermal Resistance (Typical) θ_{JA} (°C/W) θ_{JC} (°C/W)
 18 Ld CDFP Package (Notes 3, 4) TBD 8
 Storage Temperature Range -65°C to +150°C
 Junction Temperature (T_J) +175°C
 Pb-Free Reflow Profile see link below
<http://www.intersil.com/pbfree/Pb-FreeReflow.asp>

Radiation Information

High Dose(Dose Rate = 50 - 300radSi/s)100 krad(Si)
 Low Dose(Dose Rate = 10milliradSi/s)100 krad(Si)
 SET (V_{OUT} within $\pm 5\%$ During Events)86MeV/mg/cm²
 SEL/B (No Latchup/Burnout)86MeV/mg/cm²
 The output capacitance used for SEE testing is 2x100µF for C_{IN} and C_{OUT} ,
 100nF for BYPASS

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

NOTES:

- ABS max voltage rating is defined as the voltage applied for a lifetime average duty cycle above 13.2V of 1%.
- TBD (θ_{JA})
- For θ_{JC} , the "case temp" location is the center of the exposed metal pad on the package underside.
- Extended operation at these conditions may compromise reliability. Exceeding these limits will result in damage. Recommended operating conditions define limits where specifications are guaranteed.
- Electromigration specification defined as lifetime average junction temperature of +150°C where max rated DC current = lifetime average current.

Electrical Specifications

Unless otherwise noted, all parameters are guaranteed over the following specified conditions: V_{IN} = V_{OUT} + 0.5V, V_{OUT} = 4.0V, C_{IN} = C_{OUT} = 2x100µF 60mohm, AVX type TBJV107K020LBSB0023 or equivalent, T_J = +25°C, I_L = 0A

Applications must follow thermal guidelines of the package to determine worst case junction temperature. Please refer to "Applications Information" on page 6 of the data sheet and Tech Brief [TB379](#). Boldface limits apply over the operating temperature range, -55°C to +125°C. Pulse load techniques used by ATE to ensure $T_J = T_A$ defines guaranteed limits.

PARAMETER	SYMBOL	TEST CONDITIONS	MIN (Note 7)	TYP	MAX (Note 7)	UNITS
DC CHARACTERISTICS						
DC Output Voltage Accuracy	V_{OUT}	V_{OUT} Resistor adjust to : 2.5V and 5.0V				
		$V_{OUT}=2.5V$, $4.0V < V_{IN} < 5.0V$; $0A < I_{LOAD} < 1.5A$; $T_J = -55^\circ C$ to $+125^\circ C$	-1.0	0.2	1.0	%
		$V_{OUT}=5.0V$, $5.6V < V_{IN} < 6.9V$; $0A < I_{LOAD} < 1.5A$; $T_J = -55^\circ C$ to $+125^\circ C$	-1.0	0.2	1.0	%
		V_{OUT} Resistor adjust to: 10.0V				
		$V_{OUT}=10.0V$, $10.6V < V_{IN} < 13.2V$; $0A < I_{LOAD} < 1.5A$, $T_J = -55^\circ C$ to $+125^\circ C$	-1.0	0.2	1.0	%
Feedback Pin	V_{ADJ}	$T_J = -55^\circ C$ to $+125^\circ C$	596	600	604	mV
BYP Pin	V_{BYP}	$4.0V < V_{IN} < 13.2V$; $I_{LOAD}=0A$; $T_J = -55^\circ C$ to $+125^\circ C$	596	600	604	mV
DC Input Line Regulation		$4.0V < V_{IN} < 13.2V$, $V_{OUT}=2.5V$		3.13	6.25	mV
DC Input Line Regulation		$4.0V < V_{IN} < 13.2V$, $V_{OUT}=5.0V$		12.5	25	mV
DC Input Line Regulation		$10.5V < V_{IN} < 13.2V$, $V_{OUT}=10.0V$		50.0	100.00	mV
DC Output Load Regulation		$V_{OUT}=2.5V$; $0A < I_{LOAD} < 1.5A$, $V_{IN} = 4.0V$	-18.75	-7.5	-0.375	mV
DC Output Load Regulation		$V_{OUT}=5.0V$; $0A < I_{LOAD} < 1.5A$, $V_{IN} = 4.5V$	-37.5	-15.0	-0.75	mV
DC Output Load Regulation		$V_{OUT}=10.0V$; $0A < I_{LOAD} < 1.5A$, $V_{IN} = 10.5V$	-75.0	-30.0	-1.5	mV
Feedback Input Current		$V_{ADJ} = 0.6V$			1	µA
Ground Pin Current	I_Q	$V_{OUT}=2.5V$; $I_{LOAD} = 0A$, $4.0V < V_{IN} < 13.2V$	12	16	19	mA

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Electrical Specifications

Unless otherwise noted, all parameters are guaranteed over the following specified conditions: $V_{IN} = V_{OUT} + 0.5V$, $V_{OUT} = 4.0V$, $C_{IN} = C_{OUT} = 2 \times 100\mu F$ 60mohm, AVX type TBJV107K020LBSB0023 or equivalent, $T_J = +25^\circ C$, $I_L = 0A$
Applications must follow thermal guidelines of the package to determine worst case junction temperature. Please refer to "Applications Information" on page 6 of the data sheet and Tech Brief [TB379](#). **Boldface limits apply over the operating temperature range, $-55^\circ C$ to $+125^\circ C$.** Pulse load techniques used by ATE to ensure $T_J = T_A$ defines guaranteed limits.

PARAMETER	SYMBOL	TEST CONDITIONS	MIN (Note 7)	TYP	MAX (Note 7)	UNITS
Ground Pin Current	I_Q	$V_{OUT}=2.5V$; $I_{LOAD} = 1.5A$, $4.0V < V_{IN} < 13.2V$	14	20	30	mA
Ground Pin Current	I_Q	$V_{OUT}=10.0V$; $I_{LOAD} = 0A$, $10.5V < V_{IN} < 13.2V$	12	16	19	mA
Ground Pin Current	I_Q	$V_{OUT}=10.0V$; $I_{LOAD} = 1.5A$, $10.5V < V_{IN} < 13.2V$	14	20	30	mA
Ground Pin Current in Shutdown	I_{SHDNL}	ENABLE Pin = 0V, $V_{IN} = 4.0V$, $T_A = +125^\circ C$		5	220	μA
Ground Pin Current in Shutdown	I_{SHDNH}	ENABLE Pin = 0V, $V_{IN} = 13.2V$, $T_A = +125^\circ C$		5	400	μA
Dropout Voltage (Note 9)	V_{DO}	$I_{LOAD} = 0.5A$, $V_{OUT} = 3.6V$ & 10V		66	166	mV
Dropout Voltage (Note 9)	V_{DO}	$I_{LOAD} = 1.0A$, $V_{OUT} = 3.6V$ & 10V		130	330	mV
Dropout Voltage (Note 9)	V_{DO}	$I_{LOAD} = 1.5A$, $V_{OUT} = 3.6V$ & 10V		200	500	mV
Output Short Circuit Current for 16Ld FP	ISCL	$V_{OUT} = 0V$, $V_{OUT} + 0.5V < V_{IN} < 13.2V$, $R_{SET} = 6k$, Note 12)	0.4	0.5	0.75	A
Output Short Circuit Current for 16Ld FP	ISCH	$V_{OUT} = 0V$, $V_{OUT} + 0.5V < V_{IN} < 13.2V$, $R_{SET} = 600\Omega$, Note 12)	1.9	2.75	3.6	A
Output Short Circuit Current for T0257	ISCL	$V_{OUT} = 0V$, $V_{OUT} + 0.5V < V_{IN} < 13.2V$, $R_{SET} = 6k$, Note 12)	0.4	0.5	0.75	A
Output Short Circuit Current for T0257	ISCH	$V_{OUT} = 0V$, $V_{OUT} + 0.5V < V_{IN} < 13.2V$, $R_{SET} = 600\Omega$, Note 12)	2.5	3.35	4.2	A
Thermal Shutdown Temperature Note x.x) GNT	TSD	$V_{OUT} + 0.5V < V_{IN} < 13.2V$	154	175	196	$^\circ C$
Thermal Shutdown Hysteresis (Rising Threshold)	TSDn	$V_{OUT} + 0.5V < V_{IN} < 13.2V$			25	$^\circ C$
AC CHARACTERISTICS						
Input Supply Ripple Rejection	PSRR	$V_{P,P} = 300mV$, $f = 1kHz$, $I_{LOAD} = 1.5A$; $V_{IN} = 4.5V$, $V_{OUT} = 4.0V$	42	60		dB
Input Supply Ripple Rejection Note x.x) GNT	PSRR	$V_{P,P} = 300mV$, $f = 100kHz$, $I_{LOAD} = 1.5A$; $V_{IN} = 4.5V$, $V_{OUT} = 4.0V$	15	30		dB
Phase Margin, Note 8)	PM	$V_{OUT} = 2.5V, 4.0V$ & 10V $C_{OUT} = 2 \times 100\mu F$	50			dB
Gain Margin, Note 8)	GM	$V_{OUT} = 2.5V, 4.0V$ & 10V $C_{OUT} = 2 \times 100\mu F$	10			dB
Output Noise Voltage, Note 8)		$I_{LOAD} = 10mA$, $BW = 300Hz < f < 300kHz$, BYPASS to GND capacitor = $0.2\mu F$		100		μV_{RMS}
DEVICE START-UP CHARACTERISTICS						
Enable Pin Characteristics						
Turn-on Threshold		$4.0V < V_{IN} < 13.2V$	0.4	0.8	1.2	V
Enable Pin Leakage Current		$V_{IN} = 13.2V$, $EN = 5.5V$			1	μA
Enable Pin Propagation Delay (EN rise to IOUT rise)		$V_{IN}=4.5V$, $V_{OUT} = 4.0V$, $I_{LOAD} = 1.5A$, $C_{OUT} = 2 \times 100\mu F$, $C_{BYP} = 0.2\mu F$	TBD	TBD	TBD	μs
Enable Pin Turn-on Delay		$V_{IN}=4.5V$, $V_{OUT} = 4.0V$, $I_{LOAD} = 1.5A$, $C_{OUT} = 2 \times 100\mu F$, $C_{BYP} = 0.2\mu F$		6		ms
Enable Pin Turn-on Delay		$V_{IN}= 4.5V$, $V_{OUT} =4.0V$, $I_{LOAD} = 1.5A$, $C_{OUT} = 47\mu F$, $C_{BYP} = 0.2\mu F$		50		μs
Hysteresis (Falling Threshold)		Must be independent of V_{IN} , $4.0V < V_{IN} < 13.2V$	TBD	-120	TBD	mV
PG Pin Characteristics						
V_{OUT} Error Flag Rising Threshold			85	90	96	%
V_{OUT} Error Flag Falling Threshold			82	88	93	%
V_{OUT} Error Flag Hysteresis			2	2.5	3	% V_{OUT}

Electrical Specifications

Unless otherwise noted, all parameters are guaranteed over the following specified conditions: $V_{IN} = V_{OUT} + 0.5V$, $V_{OUT} = 4.0V$, $C_{IN} = C_{OUT} = 2 \times 100\mu F$ 60mohm, AVX type TBJV107K020LBSB0023 or equivalent, $T_J = +25^\circ C$, $I_L = 0A$

Applications must follow thermal guidelines of the package to determine worst case junction temperature. Please refer to "Applications Information" on page 6 of the data sheet and Tech Brief [TB379](#). Boldface limits apply over the operating temperature range, $-55^\circ C$ to $+125^\circ C$. Pulse load techniques used by ATE to ensure $T_J = T_A$ defines guaranteed limits.

PARAMETER	SYMBOL	TEST CONDITIONS	MIN (Note 7)	TYP	MAX (Note 7)	UNITS
Error Flag Low Voltage		$I_{SINK} = 1mA$		60	100	mV
Error Flag Low Voltage		$I_{SINK} = 10mA$		200	400	mV
Error Flag Leakage Current		$V_{IN} = 13.2V$, $PG = 5.5V$		0.05	1	μA

- Parameters with MIN and/or MAX limits are 100% tested at $-55^\circ C$, $+25^\circ C$ and $125^\circ C$, unless otherwise specified.
- Temperature limits established by characterization and are not production tested.
- Dropout is defined by the difference in supply V_{IN} and V_{OUT} when the supply produces a 2% drop in V_{OUT} from its nominal value.
- Refer to thermal package guidelines in "Applications Information" on page 6. (TBD)
- Minimum cap on V_{IN} and V_{OUT} required for stability.
- OCF recovery overshoot should be within $\pm 4\%$ of the nominal V_{OUT} setpoint.
- The device can work down to a V_{OUT} of 0.8V however the SET performance of $\pm 5\%$ at $LET = 86MeV.cm^2/mg$ is guaranteed at $V_{OUT} \geq 2.5V$ only. SET tests performed with $2 \times 100\mu F$ 10V 60mohm & 0.1 μF CDR04 X7R capacitor on the input and output. Capacitor on $BYP = 0.1\mu F$ CDR04 X7R

Applications Information

Input Voltage Requirements

This RH LDOs will work from a V_{IN} in the range of 4.0V to 13.2V. The input supply can have a tolerance of as much as $\pm 10\%$ for conditions noted in the specification table. The minimum guaranteed input voltage is 4.0V. However, due to the nature of an LDO, V_{IN} must be some margin higher than the output voltage plus dropout at the maximum rated current of the application if active filtering (PSRR) is expected from V_{IN} to V_{OUT} . The Dropout spec of this family of LDOs has been generously specified in order to allow applications to design for efficient operation.

External Capacitor Requirements

GENERAL GUIDELINE

External capacitors are required for proper operation. Careful attention must be paid to layout guidelines and selection of capacitor type and value to ensure optimal performance.

OUTPUT CAPACITOR

RH operation requires the use of a combination of Tantalum and Ceramic capacitors to achieve a good volume to capacitance ratio. The recommended combination is a $2 \times 100\mu F$ 60mohm, DSSC 07016 rated tantalum capacitor in parallel with a 0.1 μF MIL-PRF-49470 ceramic capacitor to be connected to V_{OUT} and Ground pins of the LDO with PCB traces no longer than 0.5cm.

INPUT CAPACITOR

RH operation requires the use of a combination of Tantalum and Ceramic capacitors to achieve a good capacitance to volume ratio. The recommended combination is a $2 \times 100\mu F$ 60mohm, DSSC 07016 rated tantalum capacitor in parallel with a 0.1 μF MIL-PRF-49470 ceramic capacitor to be connected to V_{IN} and Ground pins of the LDO with PCB traces no longer than 0.5cm.

Current Limit Protection

The RH LDO incorporates protection against overcurrent due to any short or overload condition applied to the output pin. The current limit circuit performs as a constant current source when the output current exceeds the current limit threshold which can be adjusted by means of a resistor connected between the OCP pin and GND. If the short or overload condition is removed from V_{OUT} , then the output returns to normal voltage mode regulation. In the event of an overload condition the LDO will begin to cycle on and off due to the die temperature exceeding thermal fault condition. However, one may never witness thermal cycling if the heatsink used for the package can keep the die temperature below the limits specified for thermal shutdown.

Thermal Fault Protection

In the event the die temperature exceeds typically $+170^\circ C$, then the output of the LDO will shut down to zero until the die temperature can cool down to typically $+150^\circ C$. The level of power combined with the thermal impedance of the package (R_{thJC} of $5^\circ C/W$ for the 18Ld CDFP package) will determine if the junction temperature exceeds the thermal shutdown temperature specified in the specification table (see thermal packaging guidelines).

TABLE 1.

FN#	Rev	Date	Description
SPGLD015A.0	0.0	12/10/10	First Draft
SPGLD015A.0	0.1	02/22/11	Update VINmin & VREF
SPGLD015A.0	0.2	05/23/11	Update EC table
SPGLD015A.0	0.3	06/21/11	Update pin assignment & EC table
SPGLD015A.0	0.4	07/06/11	Format, Front Page, 16Ld FP updates

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FN#	Rev	Date	Description
SPGLD015A.0	0.5	07/06/11	Change pin assignment in order to have a common die for 16ld and T0257 packages and maintain PTP.
SPGLD015A.0	0.6	09/23/11	Change pin 11 to GND and updates
SPGLD015A.0	0.7	11/16/11	Updated PG00D thresholds

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Typical Operating Performance

PLACEHOLDER

PLACEHOLDER

FIGURE 4. **TARGET** FIGURE 5.

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FIGURE 6.

FIGURE 7.

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PLACEHOLDER

FIGURE 8.

FIGURE 9.

Typical Operating Performance

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FIGURE 10.

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FIGURE 11.

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FIGURE 12.

FIGURE 13.

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PLACEHOLDER

FIGURE 14.

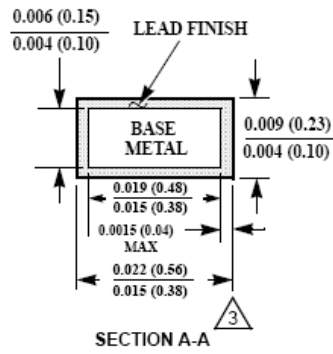
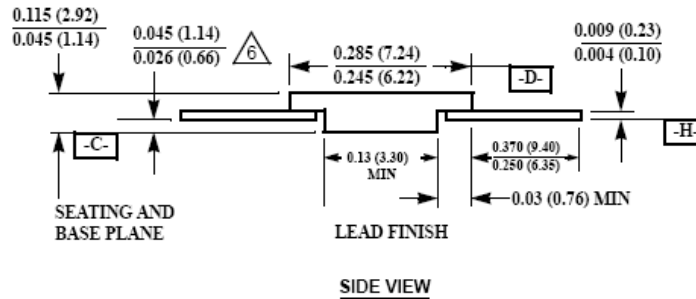
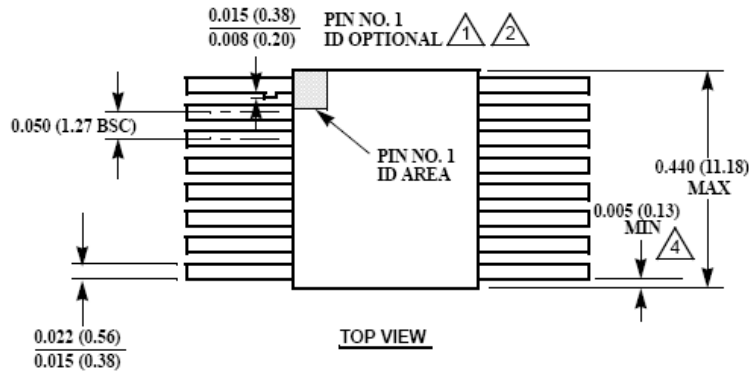
FIGURE 15.

Package Outline Drawing

K16.A

16 LEAD CERAMIC METAL SEAL FLATPACK PACKAGE

Rev 2, 1/10



NOTES:

1. Index area: A notch or a pin one identification mark shall be located adjacent to pin one and shall be located within the shaded area shown. The manufacturer's identification shall not be used as a pin one identification mark. Alternately, a tab may be used to identify pin one.
2. If a pin one identification mark is used in addition to a tab, the limits of the tab dimension do not apply.
3. The maximum limits of lead dimensions (section A-A) shall be measured at the centroid of the finished lead surfaces, when solder dip or tin plate lead finish is applied.
4. Measure dimension at all four corners.
5. For bottom-brazed lead packages, no organic or polymeric materials shall be molded to the bottom of the package to cover the leads.
6. Dimension shall be measured at the point of exit (beyond the meniscus) of the lead from the body. Dimension minimum shall be reduced by 0.0015 inch (0.038mm) maximum when solder dip lead finish is applied.
7. Dimensioning and tolerancing per ANSI Y14.5M - 1982.
8. Controlling dimension: INCH.

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DIE MAP (TBD)